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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded -</u> <u>Microcontrollers</u>"

Details

Product Status	Active
Core Processor	ARM® Cortex®-M0+
Core Size	32-Bit Single-Core
Speed	32MHz
Connectivity	I ² C, IrDA, LINbus, SPI, UART/USART, USB
Peripherals	Brown-out Detect/Reset, DMA, I ² S, LCD, POR, PWM, WDT
Number of I/O	37
Program Memory Size	192KB (192K x 8)
Program Memory Type	FLASH
EEPROM Size	6K x 8
RAM Size	20K x 8
Voltage - Supply (Vcc/Vdd)	1.8V ~ 3.6V
Data Converters	A/D 10x12b; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	48-LQFP
Supplier Device Package	48-LQFP (7x7)
Purchase URL	https://www.e-xfl.com/product-detail/stmicroelectronics/stm32l073czt6

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

Figure 43.	grid array package outline
Ū	grid array package recommended footprint
Figure 44.	UFBGA100 marking example (package top view)
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	,grid array recommended footprint
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Figure 54.	Thermal resistance



• Stop mode without RTC

The Stop mode achieves the lowest power consumption while retaining the RAM and register contents. All clocks are stopped, the PLL, MSI RC, HSI and LSI RC, HSE and LSE crystal oscillators are disabled.

Some peripherals featuring wakeup capability can enable the HSI RC during Stop mode to detect their wakeup condition.

The voltage regulator is in the low-power mode. The device can be woken up from Stop mode by any of the EXTI line, in 3.5 μ s, the processor can serve the interrupt or resume the code. The EXTI line source can be any GPIO. It can be the PVD output, the comparator 1 event or comparator 2 event (if internal reference voltage is on). It can also be wakened by the USB/USART/I2C/LPUART/LPTIMER wakeup events.

• Standby mode with RTC

The Standby mode is used to achieve the lowest power consumption and real time clock. The internal voltage regulator is switched off so that the entire V_{CORE} domain is powered off. The PLL, MSI RC, HSE crystal and HSI RC oscillators are also switched off. The LSE or LSI is still running. After entering Standby mode, the RAM and register contents are lost except for registers in the Standby circuitry (wakeup logic, IWDG, RTC, LSI, LSE Crystal 32 KHz oscillator, RCC_CSR register).

The device exits Standby mode in 60 µs when an external reset (NRST pin), an IWDG reset, a rising edge on one of the three WKUP pins, RTC alarm (Alarm A or Alarm B), RTC tamper event, RTC timestamp event or RTC Wakeup event occurs.

Standby mode without RTC

The Standby mode is used to achieve the lowest power consumption. The internal voltage regulator is switched off so that the entire V_{CORE} domain is powered off. The PLL, MSI RC, HSI and LSI RC, HSE and LSE crystal oscillators are also switched off. After entering Standby mode, the RAM and register contents are lost except for registers in the Standby circuitry (wakeup logic, IWDG, RTC, LSI, LSE Crystal 32 KHz oscillator, RCC_CSR register).

The device exits Standby mode in 60 μ s when an external reset (NRST pin) or a rising edge on one of the three WKUP pin occurs.

Note: The RTC, the IWDG, and the corresponding clock sources are not stopped automatically by entering Stop or Standby mode. The LCD is not stopped automatically by entering Stop mode.



3.6 Low-power real-time clock and backup registers

The real time clock (RTC) and the 5 backup registers are supplied in all modes including standby mode. The backup registers are five 32-bit registers used to store 20 bytes of user application data. They are not reset by a system reset, or when the device wakes up from Standby mode.

The RTC is an independent BCD timer/counter. Its main features are the following:

- Calendar with subsecond, seconds, minutes, hours (12 or 24 format), week day, date, month, year, in BCD (binary-coded decimal) format
- Automatically correction for 28, 29 (leap year), 30, and 31 day of the month
- Two programmable alarms with wake up from Stop and Standby mode capability
- Periodic wakeup from Stop and Standby with programmable resolution and period
- On-the-fly correction from 1 to 32767 RTC clock pulses. This can be used to synchronize it with a master clock.
- Reference clock detection: a more precise second source clock (50 or 60 Hz) can be used to enhance the calendar precision.
- Digital calibration circuit with 1 ppm resolution, to compensate for quartz crystal inaccuracy
- 2 anti-tamper detection pins with programmable filter. The MCU can be woken up from Stop and Standby modes on tamper event detection.
- Timestamp feature which can be used to save the calendar content. This function can be triggered by an event on the timestamp pin, or by a tamper event. The MCU can be woken up from Stop and Standby modes on timestamp event detection.

The RTC clock sources can be:

- A 32.768 kHz external crystal
- A resonator or oscillator
- The internal low-power RC oscillator (typical frequency of 37 kHz)
- The high-speed external clock

3.7 General-purpose inputs/outputs (GPIOs)

Each of the GPIO pins can be configured by software as output (push-pull or open-drain), as input (with or without pull-up or pull-down) or as peripheral alternate function. Most of the GPIO pins are shared with digital or analog alternate functions, and can be individually remapped using dedicated alternate function registers. All GPIOs are high current capable. Each GPIO output, speed can be slowed (40 MHz, 10 MHz, 2 MHz, 400 kHz). The alternate function configuration of I/Os can be locked if needed following a specific sequence in order to avoid spurious writing to the I/O registers. The I/O controller is connected to a dedicated IO bus with a toggling speed of up to 32 MHz.

Extended interrupt/event controller (EXTI)

The extended interrupt/event controller consists of 29 edge detector lines used to generate interrupt/event requests. Each line can be individually configured to select the trigger event (rising edge, falling edge, both) and can be masked independently. A pending register maintains the status of the interrupt requests. The EXTI can detect an external line with a pulse width shorter than the Internal APB2 clock period. Up to 84 GPIOs can be connected to the 16 configurable interrupt/event lines. The 13 other lines are connected to PVD, RTC, USB, USARTS, I2C, LPUART, LPTIMER or comparator events.



Table 16.	STM32L	.073xx	pin	definition	(continued)
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	Pi	n num	ber							
LQFP48	LQFP64	TFBGA64	LQFP100	UFBGA100	Pin name (function after reset)	Pin type	I/O structure	Note	Alternate functions	Additional functions
-	8	E3	15	H1	PC0	I/O	FTf	-	LPTIM1_IN1, LCD_SEG18, EVENTOUT, TSC_G7_IO1, LPUART1_RX, I2C3_SCL	ADC_IN10
-	9	E2	16	J2	PC1	I/O	FTf	-	LPTIM1_OUT, LCD_SEG19, EVENTOUT, TSC_G7_IO2, LPUART1_TX, I2C3_SDA	ADC_IN11
-	10	F2	17	J3	PC2	I/O	FTf	-	LPTIM1_IN2, LCD_SEG20, SPI2_MISO/I2S2_MCK, TSC_G7_IO3	ADC_IN12
-	11	-	18	K2	PC3	I/O	FT	-	LPTIM1_ETR, LCD_SEG21, SPI2_MOSI/I2S2_SD, TSC_G7_IO4	ADC_IN13
8	12	F1	19	J1	VSSA	S	-	-	-	-
-	-	-	20	K1	VREF-	S	-	-	-	-
-	-	G1	21	L1	VREF+	S	-	-	-	-
9	13	H1	22	M1	VDDA	S	-	-	-	-
10	14	G2	23	L2	PA0	I/O	тс	-	TIM2_CH1, TSC_G1_IO1, USART2_CTS, TIM2_ETR, USART4_TX, COMP1_OUT	COMP1_INM, ADC_IN0, RTC_TAMP2/WKUP1
11	15	H2	24	M2	PA1	I/O	FT	-	EVENTOUT, LCD_SEG0, TIM2_CH2, TSC_G1_IO2, USART2_RTS_DE, TIM21_ETR, USART4_RX	COMP1_INP, ADC_IN1
12	16	F3	25	K3	PA2	I/O	FT	-	TIM21_CH1, LCD_SEG1, TIM2_CH3, TSC_G1_IO3, USART2_TX, LPUART1_TX, COMP2_OUT	COMP2_INM, ADC_IN2
13	17	G3	26	L3	PA3	I/O	FT	-	TIM21_CH2, LCD_SEG2, TIM2_CH4, TSC_G1_IO4, USART2_RX, LPUART1_RX	COMP2_INP, ADC_IN3



Table 16. STM32	_073xx pin	definition	(continued)
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	Pi	n num	ber							
LQFP48	LQFP64	TFBGA64	LQFP100	UFBGA100	Pin name (function after reset)	Pin type	I/O structure	Note	Alternate functions	Additional functions
-	-	-	41	L8	PE10	I/O	FT	-	TIM2_CH2, LCD_SEG40, USART5_TX	-
-	-	-	42	M9	PE11	I/O	FT	-	TIM2_CH3, USART5_RX	LCD_VLCD2
-	-	-	43	L9	PE12	I/O	FT	-	TIM2_CH4, SPI1_NSS	LCD_VLCD3
-	-	-	44	M10	PE13	I/O	FT	-	LCD_SEG41, SPI1_SCK	-
-	-	-	45	M11	PE14	I/O	FT	-	LCD_SEG42, SPI1_MISO	-
-	-	-	46	M12	PE15	I/O	FT	-	LCD_SEG43, SPI1_MOSI	-
21	29	G7	47	L10	PB10	I/O	FT	-	LCD_SEG10, TIM2_CH3, TSC_SYNC, LPUART1_TX, SPI2_SCK, I2C2_SCL, LPUART1_RX	-
22	30	H7	48	L11	PB11	I/O	FT	-	EVENTOUT, LCD_SEG11, TIM2_CH4, TSC_G6_IO1, LPUART1_RX, I2C2_SDA, LPUART1_TX	-
23	31	D6	49	F12	VSS	S		-	-	-
24	32	E5	50	G12	VDD	S		-	-	-
25	33	H8	51	L12	PB12	I/O	FT	-	SPI2_NSS/I2S2_WS, LCD_SEG12, LPUART1_RTS_DE, TSC_G6_IO2, I2C2_SMBA, EVENTOUT	LCD_VLCD2
26	34	G8	52	K12	PB13	I/O	FTf	-	SPI2_SCK/I2S2_CK, LCD_SEG13, MCO, TSC_G6_IO3, LPUART1_CTS, I2C2_SCL, TIM21_CH1	-
27	35	F8	53	K11	PB14	I/O	FTf	-	SPI2_MISO/I2S2_MCK, LCD_SEG14, RTC_OUT, TSC_G6_IO4, LPUART1_RTS_DE, I2C2_SDA, TIM21_CH2	-
28	36	F7	54	K10	PB15	I/O	FT	-	SPI2_MOSI/I2S2_SD, LCD_SEG15, RTC_REFIN	-
-	-	-	55	К9	PD8	I/O	FT	-	LPUART1_TX, LCD_SEG28	-



	Pi	n num	ber							
LQFP48	LQFP64	TFBGA64	LQFP100	UFBGA100	Pin name (function after reset)	Pin type	I/O structure	Note	Alternate functions	Additional functions
47	63	D4	99	D3	VSS	S	-	-	-	-
48	64	E4	100	C4	VDD	S	-	-	-	-

Table 16. STM32L073xx pin definition (continued)

1. PA4 offers a reduced touch sensing sensitivity. It is thus recommended to use it as sampling capacitor I/O.

2. These pins are powered by VDD_USB. For all characteristics that refer to V_{DD} , V_{DD_USB} must be used instead.



6.1.6 Power supply scheme



Figure 11. Power supply scheme



Low-speed external user clock generated from an external source

The characteristics given in the following table result from tests performed using a lowspeed external clock source, and under ambient temperature and supply voltage conditions summarized in *Table 26*.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
f _{LSE_ext}	User external clock source frequency		1	32.768	1000	kHz	
V _{LSEH}	OSC32_IN input pin high level voltage		0.7V _{DD}	-	V _{DD}	V	
V _{LSEL}	OSC32_IN input pin low level voltage	-	V _{SS}	-	0.3V _{DD}		
t _{w(LSE)} t _{w(LSE)}	OSC32_IN high or low time		465	-	-	ne	
t _{r(LSE)} t _{f(LSE)}	OSC32_IN rise or fall time		-	-	10	115	
C _{IN(LSE)}	OSC32_IN input capacitance	-	-	0.6	-	pF	
DuCy _(LSE)	Duty cycle	-	45	-	55	%	
١L	OSC32_IN Input leakage current	$V_{SS} \le V_{IN} \le V_{DD}$	-	-	±1	μA	

 Table 44. Low-speed external user clock characteristics⁽¹⁾

1. Guaranteed by design, not tested in production







High-speed external clock generated from a crystal/ceramic resonator

The high-speed external (HSE) clock can be supplied with a 1 to 25 MHz crystal/ceramic resonator oscillator. All the information given in this paragraph are based on characterization results obtained with typical external components specified in *Table 45*. In the application, the resonator and the load capacitors have to be placed as close as possible to the oscillator pins in order to minimize output distortion and startup stabilization time. Refer to the crystal resonator manufacturer for more details on the resonator characteristics (frequency, package, accuracy).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit			
f _{OSC_IN}	Oscillator frequency	-	1		25	MHz			
R _F	Feedback resistor	-	-	200	-	kΩ			
G _m	Maximum critical crystal transconductance	Startup	-	-	700	μΑ /V			
t _{SU(HSE)}	Startup time	V_{DD} is stabilized	-	2	-	ms			

Table 45. HSE oscillator characteristics⁽¹⁾

1. Guaranteed by design.

 Guaranteed by characterization results. t_{SU(HSE)} is the startup time measured from the moment it is enabled (by software) to a stabilized 8 MHz oscillation is reached. This value is measured for a standard crystal resonator and it can vary significantly with the crystal manufacturer.

For C_{L1} and C_{L2} , it is recommended to use high-quality external ceramic capacitors in the 5 pF to 25 pF range (typ.), designed for high-frequency applications, and selected to match the requirements of the crystal or resonator (see *Figure 21*). C_{L1} and C_{L2} are usually the same size. The crystal manufacturer typically specifies a load capacitance which is the series combination of C_{L1} and C_{L2} . PCB and MCU pin capacitance must be included (10 pF can be used as a rough estimate of the combined pin and board capacitance) when sizing C_{L1} and C_{L2} . Refer to the application note AN2867 "Oscillator design guide for ST microcontrollers" available from the ST website *www.st.com*.



Figure 21. HSE oscillator circuit diagram



Low-speed external clock generated from a crystal/ceramic resonator

The low-speed external (LSE) clock can be supplied with a 32.768 kHz crystal/ceramic resonator oscillator. All the information given in this paragraph are based on characterization results obtained with typical external components specified in *Table 46*. In the application, the resonator and the load capacitors have to be placed as close as possible to the oscillator pins in order to minimize output distortion and startup stabilization time. Refer to the crystal resonator manufacturer for more details on the resonator characteristics (frequency, package, accuracy).

Symbol	Parameter	Conditions ⁽²⁾	Min ⁽²⁾	Тур	Max	Unit
f _{LSE}	LSE oscillator frequency		-	32.768	-	kHz
		LSEDRV[1:0]=00 lower driving capability	-	-	0.5	
G	Maximum critical crystal transconductance	LSEDRV[1:0]= 01 medium low driving capability	-	-	0.75	
G _m		LSEDRV[1:0] = 10 medium high driving capability	-	-	1.7	μΑνν
		LSEDRV[1:0]=11 higher driving capability	-	-	2.7	
t _{SU(LSE)} ⁽³⁾	Startup time	V _{DD} is stabilized	-	2	-	S

	Table 46. L	SE oscillator	characteristics ⁽¹⁾
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1. Guaranteed by design.

2. Refer to the note and caution paragraphs below the table, and to the application note AN2867 "Oscillator design guide for ST microcontrollers".

3. Guaranteed by characterization results. t_{SU(LSE)} is the startup time measured from the moment it is enabled (by software) to a stabilized 32.768 kHz oscillation is reached. This value is measured for a standard crystal resonator and it can vary significantly with the crystal manufacturer. To increase speed, address a lower-drive quartz with a high- driver mode.

Note: For information on selecting the crystal, refer to the application note AN2867 "Oscillator design guide for ST microcontrollers" available from the ST website <u>www.st.com</u>.





Note:

An external resistor is not required between OSC32_IN and OSC32_OUT and it is forbidden to add one.



6.3.7 Internal clock source characteristics

The parameters given in *Table 47* are derived from tests performed under ambient temperature and V_{DD} supply voltage conditions summarized in *Table 26*.

High-speed internal 16 MHz (HSI16) RC oscillator

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
f _{HSI16}	Frequency	V _{DD} = 3.0 V	-	16	-	MHz
trim ⁽¹⁾⁽²⁾	HSI16 user-	Trimming code is not a multiple of 16	-	± 0.4	0.7	%
	trimmed resolution	Trimming code is a multiple of 16	-	-	± 1.5	%
ACC		V _{DDA} = 3.0 V, T _A = 25 °C	-1 ⁽³⁾	-	1 ⁽³⁾	%
	Accuracy of the factory-calibrated HSI16 oscillator	V _{DDA} = 3.0 V, T _A = 0 to 55 °C	-1.5	-	1.5	%
		V_{DDA} = 3.0 V, T_A = -10 to 70 °C	-2	-	2	%
(2)		V_{DDA} = 3.0 V, T_A = -10 to 85 °C	-2.5	-	2	%
		V_{DDA} = 3.0 V, T_A = -10 to 105 °C	-4	-	2	%
		V _{DDA} = 1.65 V to 3.6 V T _A = − 40 to 125 °C	-5.45	-	3.25	%
t _{SU(HSI16)} ⁽²⁾	HSI16 oscillator startup time	-	-	3.7	6	μs
I _{DD(HSI16)} ⁽²⁾	HSI16 oscillator power consumption	-	-	100	140	μA

1. The trimming step differs depending on the trimming code. It is usually negative on the codes which are multiples of 16 (0x00, 0x10, 0x20, 0x30...0xE0).

2. Guaranteed by characterization results.

3. Guaranteed by test in production.



Figure 23. HSI16 minimum and maximum value versus temperature



Symbol	Parameter	Condition	Тур	Max	Unit	
ACC _{MSI}	Frequency error after factory calibration	-	±0.5	-	%	
	MSI oscillator frequency drift 0 °C \leq T _A \leq 85 °C	-	±3	-		
		MSI range 0	- 8.9	+7.0		
		MSI range 1	- 7.1	+5.0		
D _{TEMP(MSI)} ⁽¹⁾		MSI range 2	- 6.4	+4.0	%	
(MSI oscillator frequency drift $V_{DD} = 3.3 V 40 °C < T_{A} < 110 °C$	MSI range 3	- 6.2	+3.0		
		MSI range 4	- 5.2	+3.0		
		MSI range 5	- 4.8	+2.0		
		MSI range 6	- 4.7	+2.0		
D _{VOLT(MSI)} ⁽¹⁾	MSI oscillator frequency drift 1.65 V \leq V _{DD} \leq 3.6 V, T _A = 25 °C	-	-	2.5	%/V	
		MSI range 0	0.75	-	μA	
	MSI oscillator power consumption	MSI range 1	1	-		
		MSI range 2	1.5	-		
I _{DD(MSI)} ⁽²⁾		MSI range 3	2.5	-		
		MSI range 4	4.5	-		
		MSI range 5	8	-		
		MSI range 6	15	-		
		MSI range 0	30	-		
		MSI range 1	20	-		
		MSI range 2	15	-		
		MSI range 3	10	-		
t	MSI oscillator startun time	MSI range 4	6	-	116	
'SU(MSI)		MSI range 5	5	-	μο	
		MSI range 6, Voltage range 1 and 2	3.5	-		
		MSI range 6, Voltage range 3	5	-		

Table 50. MSI	oscillator	characteristics	(continued)
			(00011010000)



Output voltage levels

Unless otherwise specified, the parameters given in *Table 61* are derived from tests performed under ambient temperature and V_{DD} supply voltage conditions summarized in *Table 26*. All I/Os are CMOS and TTL compliant.

Symbol	Parameter	Conditions	Min	Max	Unit
V _{OL} ⁽¹⁾	Output low level voltage for an I/O pin	CMOS port ⁽²⁾ ,	-	0.4	
V _{OH} ⁽³⁾	Output high level voltage for an I/O pin	$1_{O} = +0.01$ A 2.7 V $\leq V_{DD} \leq 3.6$ V	V _{DD} -0.4	-	
V _{OL} ⁽¹⁾	Output low level voltage for an I/O pin	$\begin{array}{c} {\sf TTL \ port}^{(2)}, \\ {\sf I}_{IO} \ \mbox{=+} \ \mbox{8 mA} \\ {\sf 2.7 \ V} \le {\sf V}_{DD} \le \ \mbox{3.6 V} \end{array}$	-	0.4	
V _{OH} ⁽³⁾⁽⁴⁾	Output high level voltage for an I/O pin	$\begin{array}{l} \text{TTL port}^{(2)},\\ \text{I}_{\text{IO}} \texttt{=} -\texttt{6} \text{ mA}\\ \textbf{2.7} \text{ V} \leq \text{V}_{\text{DD}} \leq \ \textbf{3.6} \text{ V} \end{array}$	2.4	-	
V _{OL} ⁽¹⁾⁽⁴⁾	Output low level voltage for an I/O pin	I_{IO} = +15 mA 2.7 V \leq V _{DD} \leq 3.6 V	-	1.3	V
V _{OH} ⁽³⁾⁽⁴⁾	Output high level voltage for an I/O pin	$\begin{array}{l} \text{I}_{\text{IO}} \text{ = -15 mA} \\ \text{2.7 V} \leq \text{V}_{DD} \leq \ \text{3.6 V} \end{array}$	V _{DD} -1.3	-	
V _{OL} ⁽¹⁾⁽⁴⁾	Output low level voltage for an I/O pin	I_{IO} = +4 mA 1.65 V \leq V _{DD} < 3.6 V	-	0.45	
V _{OH} ⁽³⁾⁽⁴⁾	Output high level voltage for an I/O pin	I_{IO} = -4 mA 1.65 V \leq V _{DD} \leq 3.6 V	V _{DD} -0.45	-	
Va	Output low level voltage for an FTf	$I_{IO} = 20 \text{ mA} \\ 2.7 \text{ V} \le V_{DD} \le 3.6 \text{ V}$	-	0.4	
V _{OLFM+} ⁽¹⁾⁽⁴⁾	I/O pin in Fm+ mode	$I_{IO} = 10 \text{ mA} \\ 1.65 \text{ V} \le \text{V}_{DD} \le 3.6 \text{ V}$	-	0.4	

Table 61. Output voltage	characteristics
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 The I_{IO} current sunk by the device must always respect the absolute maximum rating specified in *Table 24*. The sum of the currents sunk by all the I/Os (I/O ports and control pins) must always be respected and must not exceed ΣI_{IO(PIN)}.

2. TTL and CMOS outputs are compatible with JEDEC standards JESD36 and JESD52.

3. The I_{IO} current sourced by the device must always respect the absolute maximum rating specified in Table 24. The sum of the currents sourced by all the I/Os (I/O ports and control pins) must always be respected and must not exceed $\Sigma I_{IO(PIN)}$.

4. Guaranteed by characterization results.



SPI characteristics

Unless otherwise specified, the parameters given in the following tables are derived from tests performed under ambient temperature, f_{PCLKx} frequency and V_{DD} supply voltage conditions summarized in *Table 26*.

Refer to *Section 6.3.12: I/O current injection characteristics* for more details on the input/output alternate function characteristics (NSS, SCK, MOSI, MISO).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
		Master mode			16	
		Slave mode receiver	-	-	16	
f _{SCK} 1/t _{c(SCK)}	SPI clock frequency	Slave mode Transmitter 1.71 <v<sub>DD<3.6V</v<sub>	-	-	12 ⁽²⁾	MHz
		Slave mode Transmitter 2.7 <v<sub>DD<3.6V</v<sub>	-	-	16 ⁽²⁾	
Duty _(SCK)	Duty cycle of SPI clock frequency	Slave mode	30	50	70	%
t _{su(NSS)}	NSS setup time	Slave mode, SPI presc = 2	4*Tpclk	-	-	
t _{h(NSS)}	NSS hold time	Slave mode, SPI presc = 2	2*Tpclk	-	-	
t _{w(SCKH)} t _{w(SCKL)}	SCK high and low time	Master mode	Tpclk-2	Tpclk	Tpclk+ 2	
t _{su(MI)}	Data input actus timo	Master mode	0	-	-	
t _{su(SI)}	Data input setup time	Slave mode	3	-	-	
t _{h(MI)}	Data input hold time	Master mode	7	-	-	
t _{h(SI)}	Data input noid time	Slave mode	3.5	-	-	ns
t _{a(SO}	Data output access time	Slave mode	15	-	36	
t _{dis(SO)}	Data output disable time	Slave mode	10	-	30	
t _{v(SO)}		Slave mode 1.65 V <v<sub>DD<3.6 V</v<sub>	-	18	41	
	Data output valid time	Slave mode 2.7 V <v<sub>DD<3.6 V</v<sub>	-	18	25	
t _{v(MO)}		Master mode	-	4	7	
t _{h(SO)}	Data output hold time	Slave mode	10	-	-	
t _{h(MO)}		Master mode	0	-	-	

1. Guaranteed by characterization results.

2. The maximum SPI clock frequency in slave transmitter mode is determined by the sum of $t_{v(SO)}$ and $t_{su(MI)}$ which has to fit into SCK low or high phase preceding the SCK sampling edge. This value can be achieved when the SPI communicates with a master having $t_{su(MI)} = 0$ while Duty_(SCK) = 50%.



Symbol	Parameter	Conditions	Min	Тур	Max	Unit
		Master mode			8	
f _{SCK}	SPI clock frequency	Slave mode Transmitter 1.65 <v<sub>DD<3.6V</v<sub>	_	-	8	MHz
		Slave mode Transmitter 2.7 <v<sub>DD<3.6V</v<sub>			8 ⁽²⁾	
Duty _(SCK)	Duty cycle of SPI clock frequency	Slave mode	30	50	70	%
t _{su(NSS)}	NSS setup time	Slave mode, SPI presc = 2	4*Tpclk	-	-	
t _{h(NSS)}	NSS hold time	Slave mode, SPI presc = 2	2*Tpclk	-	-	
t _{w(SCKH)} t _{w(SCKL)}	SCK high and low time	Master mode	Tpclk-2	Tpclk	Tpclk+2	
t _{su(MI)}	Deta input actua tima	Master mode	0	-	-	
t _{su(SI)}	Data input setup time	Slave mode	3	-	-	
t _{h(MI)}	Data input hold time	Master mode	11	-	-	
t _{h(SI)}	Data input hold time	Slave mode	4.5	-	-	ns
t _{a(SO}	Data output access time	Slave mode	18	-	52	
t _{dis(SO)}	Data output disable time	Slave mode	12	-	42	
t _{v(SO)}	Data output valid time	Slave mode	-	20	56.5	
t _{v(MO)}		Master mode	-	5	9	
t _{h(SO)}	Data output hold time	Slave mode	13	-	-	
t _{h(MO)}		Master mode	3	-	-	

	_					. (4	i \
Table 76.	SPI	characteristics	in	voltage	Range	2 ()

1. Guaranteed by characterization results.

2. The maximum SPI clock frequency in slave transmitter mode is determined by the sum of $t_{v(SO)}$ and $t_{su(MI)}$ which has to fit into SCK low or high phase preceding the SCK sampling edge. This value can be achieved when the SPI communicates with a master having $t_{su(MI)} = 0$ while Duty_(SCK) = 50%.



Symbol	Parameter	Conditions	Min	Тур	Max	Unit
f _{scк}	SDI alook fraguanov	Master mode			2	
1/t _{c(SCK)}	SFI Clock frequency	Slave mode	-	-	2 ⁽²⁾	
Duty _(SCK)	Duty cycle of SPI clock frequency	Slave mode	30	50	70	%
t _{su(NSS)}	NSS setup time	Slave mode, SPI presc = 2	4*Tpclk	-	-	
t _{h(NSS)}	NSS hold time	Slave mode, SPI presc = 2	2*Tpclk	-	-	
t _{w(SCKH)} t _{w(SCKL)}	SCK high and low time	Master mode	Tpclk-2	Tpclk	Tpclk+2	
t _{su(MI)}	Data input satur timo	Master mode	1.5	-	-	
t _{su(SI)}		Slave mode	6	-	-	
t _{h(MI)}	Data input hold time	Master mode	13.5	-	-	
t _{h(SI)}		Slave mode	16	-	-	ns
t _{a(SO}	Data output access time	Slave mode	30	-	70	
t _{dis(SO)}	Data output disable time	Slave mode	40	-	80	
t _{v(SO)}	Data output valid time	Slave mode	-	30	70	
t _{v(MO)}		Master mode	-	7	9	
t _{h(SO)}	Data output hold time	Slave mode	25	-	-	
t _{h(MO)}		Master mode	8	-	-	

						(4)
Table 77.	SPI ch	aracteristics	in v	oltage	Range	3 (1)

1. Guaranteed by characterization results.

2. The maximum SPI clock frequency in slave transmitter mode is determined by the sum of $t_{v(SO)}$ and $t_{su(MI)}$ which has to fit into SCK low or high phase preceding the SCK sampling edge. This value can be achieved when the SPI communicates with a master having $t_{su(MI)} = 0$ while Duty_(SCK) = 50%.



Figure 33. SPI timing diagram - slave mode and CPHA = 0





Figure 34. SPI timing diagram - slave mode and CPHA = $1^{(1)}$

1. Measurement points are done at CMOS levels: $0.3V_{DD}$ and $0.7V_{DD}$.



Figure 35. SPI timing diagram - master mode⁽¹⁾



^{1.} Measurement points are done at CMOS levels: $0.3V_{\text{DD}}$ and $0.7V_{\text{DD}}$

7 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status *are available at www.st.com*. ECOPACK[®] is an ST trademark.

7.1 LQFP100 package information



Figure 39. LQFP100 - 100-pin, 14 x 14 mm low-profile quad flat package outline

1. Drawing is not to scale. Dimensions are in millimeters.



Date	Revision	Changes
22-Mar-2016	3	Updated number of SPIs on cover page and in <i>Table 2: Ultra-low-power STM32L073xxx device features and peripheral counts.</i> Changed minimum comparator supply voltage to 1.65 V on cover page. Added minimum DAC supply voltage on cover page. Added number of fast and standard channels in <i>Section 3.12:</i> <i>Analog-to-digital converter (ADC).</i> Updated <i>Section 3.18.2: Universal synchronous/asynchronous</i> <i>receiver transmitter (USART)</i> and <i>Section 3.18.4: Serial</i> <i>peripheral interface (SPI)/Inter-integrated sound (I2S)</i> to mention the fact that USARTs with synchronous mode feature can be used as SPI master interfaces. Added baudrate allowing to wake up the MCU from Stop mode in <i>Section 3.18.2: Universal synchronous/asynchronous receiver</i> <i>transmitter (USART)</i> and <i>Section 3.18.3: Low-power universal</i> <i>asynchronous receiver transmitter (LPUART).</i> <i>Section 6.3.15: 12-bit ADC characteristics:</i> – <i>Table 64: ADC characteristics:</i> Distinction made between V _{DDA} for fast and standard channels; added note 1. Added note 4. related to R _{ADC} . Updated f _{TRIG} . Updated f _S and t _{CONV} . – Updated equation 1 description. – Updated Table 65: RAIN max for fADC = 16 MHz for f _{ADC} = 16 MHz and distinction made between fast and standard channels. Updated R _O and added Note 2. in <i>Table 67: DAC characteristics:</i> Added <i>Table 74: USART/LPUART characteristics.</i>

Table 92. Document revision history



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